

PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

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APPL NUM	FILING DATE	CLASS	SUBCLASS		Ciril	EXAMINER 1691	- 1		
10038717	01/08/2002	435		1845					
**APPLICANTS: Wakabayashi Yuki; Kambara Hideki; Zhou Guohua; Kamahon Masao;									
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Foreign priority c			es 🗆 no		ATTO	ORNEY DOCKET NO			
35 USC 119 conditions met □ yes □ no NITT.00 Verified and Acknowledged Examiners's initials						.0052			
TITLE : Metho	d of analysis of DN	IA seque	nce		u.s.D	EPT, OF COMM.PAT.& TM-PTO-436	L(Rev. 12-94)		
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		Assistant Examiner	Total Claims		Print Claim for Q.G	
ISSUE FEE		·	DRAWING			
Amount Due	Date Peld		Sheets Drwg.	Figs.Drwg.	Print Fig.	
		Primary Examiner				
TERMINAL DISCLAMER		PREPARED FOR ISSUE	Application Examiner			
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